Notice of References Cited	Application/Control No. 10/686,095	Applicant(s)/Patent Under Reexamination PARK ET AL.	
	Examiner Sam K. Ahn	Art Unit 2611	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,112,094	08-2000	Dent, Paul W.	455/452.1
*	B	US-6,351,643 B1	02-2002	Haartsen, Jacobus C.	455/450
*	C	US-7,116,699 B2	10-2006	Batra et al.	375/132
*	D	US-2003/0147453 A1	08-2003	Batra, Anuj	375/132
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Komo et al. Maximal Length Sequence for Frequency Hopping, June 1990, IEEE Vol.8, No.5, p.819-822
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.